

<b>Notice of References Cited</b>	Application/Control No. 10/592,909		Applicant(s)/Patent Under Reexamination MONZON-SIMON ET AL.	
	Examiner Eduardo Colon-Santana		Art Unit 2837	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,138,798 A	10-2000	Macuga, Henry J.	187/294
*	B	US-6,173,814 B1	01-2001	Herkel et al.	187/288
*	C	US-6,481,534 B1	11-2002	Malone, Jr., Thomas F.	187/377
*	D	US-6,550,585 B2	04-2003	Schoppa et al.	187/391
*	E	US-7,140,473 B2	11-2006	Det et al.	187/401
*	F	US-2007/0240942 A1	10-2007	Sirigu, Gerard	187/360
*	G	US-7,281,609 B2	10-2007	Del Rio Sanz et al.	187/316
*	H	US-2008/0047783 A1	02-2008	Vogl, Wolfgang	187/314
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	GB 2158038 A	11-1985	United Kingdom	BUCK et al.	E04G 01/26
	O	JP 02291377 A	12-1990	Japan	MIZUNO, YUKIOMI	B66B 05/00
	P	EP 1167268 A1	01-2002	European Patent	ISHII et al.	B66B 05/00
	Q	JP 2002003113 A	01-2002	Japan	MIZUMOTO, MASAHIKO	B66B 05/00
	R	DE 10052459 A1	05-2002	Germany		B66B 05/00
	S	JP 2006199404 A	08-2006	Japan	KUBOTA, TAKEHIKO	
	I					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.